

## Description:

- 1) A package of series of two chips.
- 2) With high thermal conductivity DBC as the insulation.
- 3) Welding by vacuum welding technology, which provide high reliability.

## Typical Application:

DC motor control, temperature control and light control system.



## Absolute Maximum Ratings (Packaged into modules, unless otherwise specified, $T_{CASE}=25^{\circ}C$ )

Parameter	Test Conditions	Symbol	Values			Unit
			12	16	18	
Operating junction temperature range		$T_j$	-40-125			$^{\circ}C$
Storage temperature range		$T_{stg}$	-40-125			$^{\circ}C$
Repetitive peak off-state voltage	$T_j=25^{\circ}C$	$V_{DRM}$	1200	1600	1800	V
Repetitive peak reverse voltage	$T_j=25^{\circ}C$	$V_{RRM}$	1200	1600	1800	V
Non-repetitive peak off-state voltage	$T_j=25^{\circ}C$	$V_{DSM}$	1300	1700	1900	V
Non-repetitive peak reverse voltage	$T_j=25^{\circ}C$	$V_{RSM}$	1300	1700	1900	V
Average on-state current	$T_C=85^{\circ}C$	$I_{T(AV)}/I_{F(AV)}$	120			A
Peak on-state surge current	$t_p=10ms$ $V_R=0.6V_{RRM}$	$I_{TSM}/I_{FSM}$	2500			A
$I^2t$ value for fusing	$t_p=10ms$ $V_R=0.6V_{RRM}$	$I^2t$	31250			$A^2s$
Critical rate of rise of on-state current	$I_G=2 \times I_{GT}$	$di/dt$	150			$A/\mu s$
Isolation voltage	A.C 50Hz(1s/1min)	$V_{ISO}$	3600/3000			V

## Electrical Characteristics (Packaged into modules, unless otherwise specified, $T_{CASE}=25^{\circ}C$ )

Parameter	Test Conditions	Symbol	Values	Unit
Peak on-state voltage	$I_T=360A$ $t_p=380\mu s$	$V_{TM}$	$\leq 1.8$	V
Threshold voltage	$T_j=125^{\circ}C$	$V_{TO}$	$\leq 0.95$	V
Dynamic resistance	$T_j=125^{\circ}C$	$R_d$	$\leq 2.1$	m $\Omega$
Repetitive peak off-state current	$V_D=V_{DRM}$ $T_C=25^{\circ}C$	$I_{DRM1}$	$\leq 100$	$\mu A$
	$T_C=125^{\circ}C$	$I_{DRM2}$	$\leq 40$	mA
Repetitive peak reverse current	$V_R=V_{RRM}$ $T_C=25^{\circ}C$	$I_{RRM1}$	$\leq 100$	$\mu A$
	$T_C=125^{\circ}C$	$I_{RRM2}$	$\leq 40$	mA
Triggering gate current	$V_D=12V$ $R_L=30\Omega$	$I_{GT}$	20-120	mA
Holding current	$I_T=1A$	$I_H$	$\leq 250$	mA
Latching current	$I_G=1.2 I_{GT}$	$I_L$	$\leq 300$	mA
Triggering gate voltage	$V_D=12V$ $R_L=30\Omega$	$V_{GT}$	$\leq 1.8$	V
Non triggering gate voltage	$V_D=V_{DRM}$ $T_j=125^{\circ}C$	$V_{GD}$	$\geq 0.25$	V
Critical rate of rise of voltage	$V_D=2/3V_{DRM}$ $T_j=125^{\circ}C$ Gate Open	$dv/dt$	$\geq 1000$	V/ $\mu s$
Thermal resistance	Junction to case	$R_{th(j-c)}$	0.29	$^{\circ}C/W$
	Case to heatsink	$R_{th(c-s)}$	0.21	

**Mechanical Characteristics**

Module size	93.5mm×21mm
Module height	31mm
Terminal distance of (1)/(2)/(3)	20mm
Mounting torque(M5)	5±15%Nm
Terminal torque(M5)	3±15%Nm

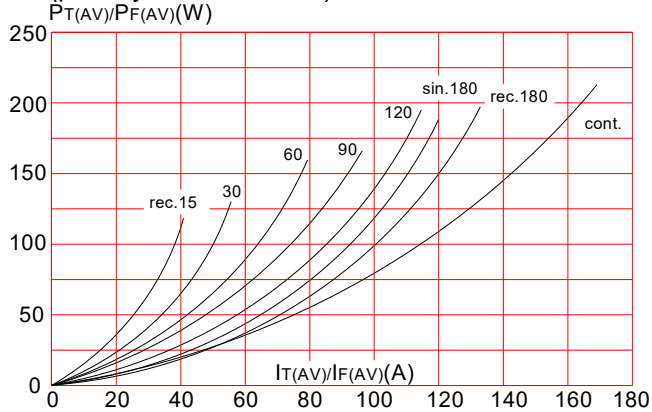
T1

AKMD symbol

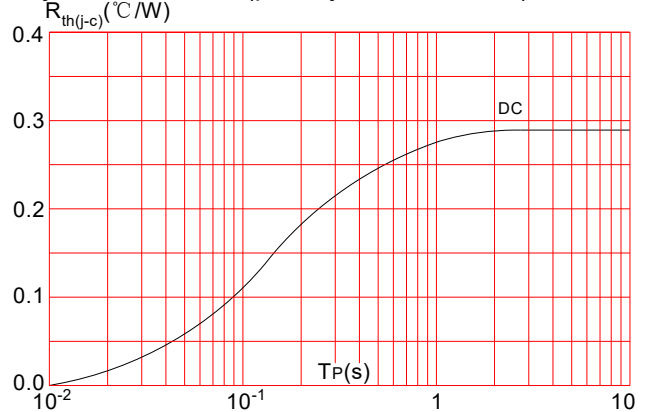
AKMH symbol

**Performance Curves**

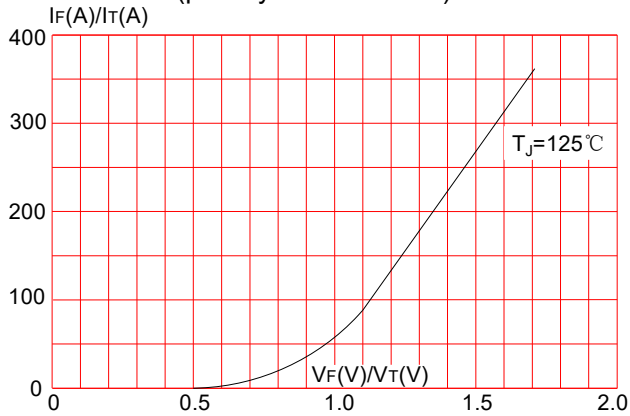
**FIG.1: Power dissipation vs. on-state current (per thyristor or diode)**



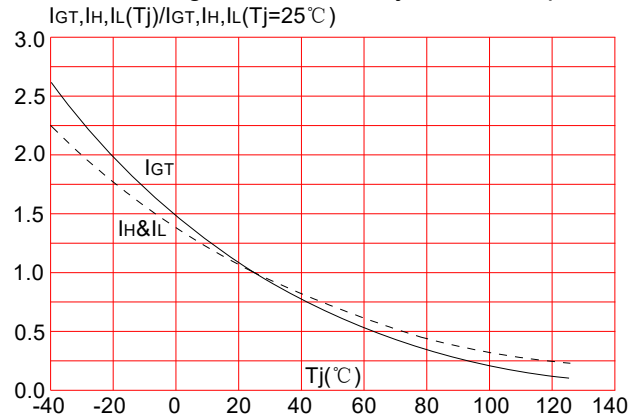
**FIG.2: Maximum transient thermal impedance junction to case(per thyristor or diode)**



**FIG.3:** Forward characteristics (per thyristor or diode)



**FIG.4:** Relative variations of gate trigger current, holding current and latching current versus junction temperature



**Ordering Information**

<p><b>AK</b></p> <p>Aiko Electronics Technology Co., LTD</p>	<p><b>MD</b></p> <p>MD: Thyristor module MH: Thyristor and diode module</p>	<p><b>120</b></p> <p><math>I_T(AV) / I_F(AV) = 120A</math></p>	<p><b>/</b></p>	<p><b>16</b></p> <p>12: <math>V_{DRM} / V_{RRM} \geq 1200V</math> 16: <math>V_{DRM} / V_{RRM} \geq 1600V</math> 18: <math>V_{DRM} / V_{RRM} \geq 1800V</math></p>
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